Random bad cell map for wafer 175 s/n: Y21316-09-10

Date: 07/07/99

		0		0				
		0		0	0	0		
	0	0	0	0	0	0	0	
	0	0	4			0	0	
0	0	0	0	0	0	0	0	0
0	0	0	2	2		0	0	0
	0	0	0		0	0	0	0
0	0	1	0	2	1	0	0	
0		3	1	0	2	0	0	
0		3	0		0		0	
0	0	0	0	0	2		0	0
33	0	5	0	0	1	0	0	0
0	0	0	0	0	0	1	0	0
	0	0	0	0	0	0	0	
	0	0	0	0		0	1	
	0	0		0	1	0	0	
		0	0	0	0	0		
			0		0	0		

#	Number of bad cells in random locations
	No info